

Search Notes**Application/Control No.**

10/543,092

Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

MIYAMATSU ET AL.

Art Unit

1795

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|---------|----------|
| 430 | 270.1 | 12/2007 | JS |
| 430 | 905 | | |
| 430 | 910 | | |
| 430 | 922 | | |
| 549 | 13 | | |
| 549 | 29 | | |
| 549 | 88 | | |
| 549 | 90 | | |
| 568 | 27 | | |
| 568 | 28 | | |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------|---------|------|
| UPDATED | 12/2007 | JS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|------------------|-----------|---------|----------|
| 430 | 270.1,905 | 12/2007 | JS |
| 430 | 910,922 | | |
| 549 | 13,29,88 | | |
| 549/90;568/27,28 | | | |
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